**Feature Selection Based on Improved Particle Swarm Optimization in Software Defect Prediction**

Afnan Alotaibi1, Nada Alsulaiman2, Nojoud Albadrani3, Sultan Alqahtani4, Wojdan Binsaeedan5

Computer Sciences Department, Imam Mohammad Ibn Saud Islamic University

Riyadh, Saudi Arabia

1atsalotaibi, 2nfsulaiman, 3nfalbadrani {@sm.imamu.edu.sa}, 4ssalqahtani, 5wmasaeedan{@imamu.edu.sa}

ABSTRACT

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# Introduction

Software Defect Prediction (SDP) is one of the important processes in the software development lifecycle (SDLC) [1]. SDP is the process of identifying and controlling the percentage of defective program units in the software [2] [3]. Defect prediction will improve the testing process and the overall quality of the software [3]. In addition, it will decrease the time, cost, the effort required to rework on the defective units and deliver a more consistent and trusted software [2]. Software defect prediction field started in the 1970s, and now the field have hundreds of related software defect prediction models [4]. In recent studies, SDP models were built using different Machine learning algorithms [5]. The accuracy of SDP models is highly affected by the quality of defect datasets used to build SDP models [6]. The defect dataset features or attributes are growing vastly as software systems are increasing; accordingly, these datasets may contain irrelevant and redundant features that affect the accuracy of classifiers [7] [6].Feature selection (FS) is used to achieve the best classification performance by selecting the most informative feature subset from the dataset [8]. However, FS is an NP-Hard problem because the number of search space increases exponentially when the number of features is increased [7] [9]. Thus, metaheuristic search algorithms are used to find the optimal subset of features within less time [10]. It is random-based methods that generate random solutions and can reach a near-optimal solution [9]. Swarm Intelligence (SI) algorithms are one of the metaheuristic algorithms that are inspired by the behaviours of the creatures such as bees, birds, and fishes [9]. SI algorithms involve two main processes which are exploration and exploitation. Exploration means examine more global regions and find the diverse solution. In contrast, the exploitation is searching locally to enhance the quality of the solution [9]. Over exploration or over explotation can leads to losses the optimal solution, or premature convergence and suck in local minima [9]. Thus, achieving balance between exploration and exploitation is important for the optimization process.

# Background

This section handles a background on the main related concepts to the SDP and FS. First, the section provides an overview of SDP process. Then, we give a brief description of FS process and its approaches. In addition, we provide an overview of the used classifiers.

## Software Defect Prediction (SDP)

The software is exposed to defect during SDLC stages, defect could be arise from the ambiguity of the requirements due to the miscommunication in the requirements elicitation stage, lack of experience in the domain, involving developers with poor technical and programming skills and so forth [3]. Delivering a software with defect will cause huge losses[11]. Customers satisfaction is an important issue for any product, Therefore, to deliver a high quality software, the software has to be achieve customer requirements, and developed within the available budget, time [12]. SDP is important before testing operations take place [3]. Software Quality Assurance (SQA) task consumes (30% - 90%) of the budget of the software project [13]. Therefore, Identifying defective modules and managing the defects in the software will improves the testing process, where it focus on modules that are more expected to work incorrectly [14]. There are three different categories of SDP, prediction the number of defects, the severity of defects and the most frequently used is the prediction of whether the software unit is defective or not [3], where the SDP is used as a binary classification problem that has two classes which are defect and non-defect [15].

## Feature Selection (FS)

Feature selection method used to select a subset of the space of features in order to remove the irrelevant features, and to simplify data mining procedures when dealing with large datasets by removing unnecessary and/or duplicate features.[6]. Accordingly, FS method enhance the prediction process and the performance of the classifiers [7]. With the advent of improved data collecting techniques, the FS step has become critical and required for improving the mining process' performance. The most difficult aspect of the FS process is determining the ideal feature combination [16]. For datasets with a small number of features, the full (exhaustive) search, which tests all potential combinations before selecting the best one, or the exact search methods can be used. When working with high-dimensional datasets, when the search space is exponentially extended, these search algorithms become impractical and time-consuming. To put it another way, the search space for a dataset with N features consists of (2N-1) feature subsets [17]. As a result, metaheuristics algorithms are the best alternative to the search techniques stated above.

There are two main approaches to feature subset selection used in machine learning: filter, wrapper and . Filter-based approach (FFS) selects subsets of features based on the characteristics of the dataset and exclusively independent of the chosen predictor [6][18]. Accordingly, The advantages of FFS that has a low computational cost and high scalability [6]. Wrapper based approaches (WFS) utilize a prediction model to assess relative usefulness of subsets of features [6][18]. In contrast to the FFS, that asses each feature independently, considering the interdependencies of each feature with the prediction model makes the WFS more WFS accurate [6][19]. Accordingly, this methods are computationally expensive but are more superior to FFS based on existing studies [19][20][21]. In addition to these two main approaches there is a hybrid technique of both filter and wrapper which is embedded method. In the embedded method, filter method is applied to the initial features to find the best features using some independent criteria; then wrapper method is applied to the same subset and evaluated using the learning algorithm, to find the accuracy [22][2]. Embedded method is less computationally expensive as compared to the wrapper method [22].

## Classification Algorithms

In this study, three classifiers were used to study the effect of the FS on these classifiers and to compare results and measure the improvement. The following subsections provide a brief description of each classifier.

### Naive Bayes Classifier (NB)

NB is a probabilistic classifier that based on Bayes’ theorem [3].It is assume that there is a strong independence among all the features and they are equally significant [17] [2]. The main advantage of the NB classifier is its short computational time for training [17].

### K-Nearest Neighbor Classifier (KNN)

KNN is a classification method that is part of a wider family of pattern recognition algorithmes known as lazy learning or instance-based algorithms [3]. They are based on determining the similarities between the unlabeled new query instance and its nearest k neighbors from the labeled training instance stored in memory rather than performing the generalization in an explicit training phase. The fundamental principle behind k-NN is that close points in space are likely to have similar class concepts. The input to the k-NN in classification problems is the k closest examples among the training examples, and the output is the labels of these instances. For a given example, labeling is determined by the majority of votes cast by the k nearest neighbors. The comparison and computation of the distance between two points are based on a predefined distance metric, such as the Euclidean distance [3].

### Support Vector Machines (SVM)

SVM is a supervised learning methods used to analyze data for classification and regression analysis [23]. It was proposed by Vapnik in 1995 [23] . The main idea of SVM is to divides the available data set into two groups by a hyperplane [2] in order to to maximize the distance between the two groups [3]. SVM is a binary classifier that used a linear method in addition to non-linear classification [3].

## Overview of Particle Swarm Optimization (PSO)

PSO is an meta-heurstic technique inroduced by Kennedy and Eberhart [24] that was inspired by social behaviors seen in birds flocking and fish schooling. A swarm in PSO is made of multiple individuals known as particles who communicate through iterations to identify optimal solutions while traversing around the search space. PSO performs searches using a population (swarm) of individuals (particles) that are updated from iteration to iteration. The population size is denoted as psize. To find the optimal solution, each particle modifies its search direction based on two factors: its own best prior experience (pbest) and the best experience of all other members (gbest).

### Binary Particle Swarm Optimization for Feature Selection

Many optimization problems in a space are discrete, Binary particle swarm optimization (BPSO) has been proposed to solve these types of tasks [25]. Its another version of PSO that utilize the personal best (pbest) and global best (gbest) solutions to update the velocity and position[26]. The volicity will updated as following for each particle [26] [27] :

where is the velocity, is the inertia weight, and are the acceleration factors, and are two independent random numbers between 0 and 1, is the position of particle (solution), is the personal best solution, is the global best solution for the population, is the order of particle in the population, is the dimension of search space, and is the number of iterations. All the random numbers will be discussed in the experiments section. ~~Note that the velocity is bounded by the maximum velocity, vmax and minimum velocity, vmin. In this study, the vmax and vmin were set at 6 and −6, respectively [13]~~.

In BPSO, probabilities are used to determine the state of one bit, in other word, a particle moves in a state space constrained to zero and one on each dimension, for example if = 0.20, then will be near to zero more than one [25]. After the velocity is calculated using Equation (1) , it will converted into probability value using Equation (2), is known as a transfer function [28].

The position of particle is updated as shown in Equation (3):

where is a random number between 0 and 1. Considering the minimization function that applied in this paper pbest and gbest is iteratively updated as follows:

where is the solution, F(.) is the fitness function, and is the number of iterations.

# Related work

Several research papers in the literature investigate the SDP problem. However, the most recent studies used machine learning approaches to create an appropriate model for this complex challenge. Some studies used pure machine learning methods with no pre-processing on the input datasets [29]. In contrast, others used a combination of pre-processing methods on the datasets, such as feature selection to lower the dimensionality of input datasets or noise reduction from unbalanced datasets. This section will review the works that used the PSO for features selection to improve SDP.

Wahono and Suryana [30] presented a PSO-bagging approach combination to improve the performance of software defect prediction. PSO was employed to deal with feature selection, while the bagging approach was utilized to deal with class imbalance. In order to evaluate the suggested strategy, many machine learning classifiers were applied to nine datasets from NASA’s metric data repository. The AUC results showed that the proposed technique enhanced the prediction performance of the most commonly used ML classifiers. Wahono and Ahmad published similar work in [31], in which GA and PSO algorithms were used as feature selection strategies for the SFP problem, while the bagging methodology was used to deal with the class imbalance problem. To test various FS techniques, ten classifiers were used across nine NASA MDP datasets. The AUC results revealed that the proposed FS techniques resulted in a major improvement in prediction performance for the majority of the used classifiers. Furthermore, it has been determined that there is no substantial difference between PSO and GA in feature selection for the majority of classifiers.

Arora and Saha [1] introduced a software defect prediction model based on two classifiers, extreme learning machine (ELM) and kernel-based ELM (KELM). They employed five wrapper-based including PSO and seven filter-based feature selection approaches in their approach. They chose seven datasets from the PROMISE repository to test their method. Furthermore, they employed the accuracy metric to assess the performance feature selection model. They discovered that ELM-based classifiers worked better with wrapper-based feature selection approaches, but KELM classifiers performed better with filter-based methods.

Recently, Malhorta et al. [32] used the Synthetic Minority Oversampling Technique (SMOTE) along with FS using PSO on object-oriented metrics. First, the SMOTE were used to tackle the issue of imbalanced data, while the PSO was applied to extract the optimal feature set. Then, the chosen features were utilized for training the SVM to predict defects. The result showed that the oversampling technique of SMOTE when combined with PSO for feature selection, can be used for building efficient software defect production models.

As shown by past literature, several research publications examine the SDP problem. However, in reality, each project has its characteristics. Thus, it is critical to design a strong model that evaluates the acquired data early in the process. This encourages us to improve the PSO algorithm to use it as a feature selection algorithm as the initial step toward achieving a high-quality classifier.

# Datasets Specifications

We experimented the proposed method on different benchmarked datasets extracted from the PROMISE repositoryand NASA repository. The datasets were collected from real and open-source software projects. Eleven of these datasets are downloaded from the NASA corpus[[1]](#footnote-2) (cleaned versions by [33]), while the remaining datasets are from the PROMISE software engineering corpus[[2]](#footnote-3). These projects have different specifications, such as the programming language, the code size, and software measures, Detailed information on the datasets is listed in Table 1. PROMISE dataset has 20 static attributes and one dependent variable. for each software project. On the other hand, NASA datasets have different number of attributes for each software project. The datasets consist of a set of features that have values and a goal field that describes the instance as defect or non-defect. These features describe the program from different sides including the lines of code measure (program length, count of lines of comments, count of lines of comments), McCabe metrics, base Halstead measures, derived Halstead measures, unique operators, unique operands, total operators, total operands, cyclomatic complexity, essential complexity, design complexity, and a branch-count. . We choose PROMISE and NASA because these datasets are commonly used in SDP field.

The approach for applying training and testing in the experiments is based on a hold-out strategy in which each dataset is randomly divided into 70% for training and 30% for testing.

|  |  |  |  |  |  |  |  |  |  |  |
| --- | --- | --- | --- | --- | --- | --- | --- | --- | --- | --- |
| Table 1: *Datasets description.* | | | | | | | | | | |
|  | No. | Project | | Language | | Features | Instances | Defects | Non- Defects | Defect ratio | |
| PROMISE | D1 | | ant-1.7 | | Java | 21 | 745 | 166 | 579 | 22.3 | |
| D2 | | camel-1.6 | | Java | 21 | 965 | 188 | 777 | 19.5 | |
| D3 | | ivy-2.0 | | Java | 21 | 352 | 40 | 312 | 11.4 | |
| D4 | | jedit-4.3 | | Java | 21 | 492 | 11 | 481 | 2.2 | |
| D5 | | log4j-1.2 | | Java | 21 | 205 | 189 | 16 | 92.2 | |
| D6 | | lucene-2.4 | | Java | 21 | 340 | 203 | 137 | 59.7 | |
| D7 | | poi-3.0 | | Java | 21 | 442 | 281 | 161 | 63.6 | |
| D8 | | tomcat-6 | | Java | 20 | 858 | 77 | 781 | 9 | |
| D9 | | xalan-2.6 | | Java | 21 | 885 | 411 | 474 | 46.4 | |
| D10 | | xerces-1.4 | | Java | 21 | 588 | 437 | 151 | 74.3 | |
| NASA | D11 | | cm1 | | C | 38 | 327 | 42 | 285 | 12.8 | |
| D12 | | jm1 | | C | 22 | 7782 | 1672 | 6110 | 21.5 | |
| D13 | | kc1 | | C++ | 22 | 1183 | 314 | 869 | 26.5 | |
| D14 | | kc3 | | Java | 40 | 194 | 36 | 158 | 18.6 | |
| D15 | | mc1 | | C & C++ | 39 | 1988 | 46 | 1942 | 2.3 | |
| D16 | | mw1 | | C | 38 | 253 | 27 | 226 | 10.7 | |
| D17 | | pc1 | | C | 38 | 705 | 61 | 644 | 8.7 | |
| D18 | | pc2 | | C | 37 | 745 | 16 | 729 | 2.1 | |
| D19 | | pc3 | | C | 38 | 1077 | 134 | 943 | 12.4 | |
| D20 | | pc4 | | C | 38 | 1287 | 177 | 1110 | 13.8 | |
| D21 | | pc5 | | C++ | 39 | 1711 | 471 | 1240 | 27.5 | |

# Methodology

This section provides an overview of the methodology that is used in this article, which clarifies all the inputs, outputs, algorithms, and procedural phases. The proposed approach is a software defect prediction model that consists of integrating sticky binary particle swarm algorithm with different classifiers; to the best of our knowledge, this approach will be used for the first time to predict software defect, and Figure 1 illustrates the proposed approaches in this article.

|  |  |  |  |
| --- | --- | --- | --- |
| Parameters | Without FS | BPSO | Proposed method SBPSO |
| Population size, N |  |  |  |
| Maximum number of iterations, Tmax |  |  |  |
| Number of runs |  |  |  |
| w |  |  |  |
| c1 |  |  |  |
| c2 |  |  |  |
| vmax |  |  |  |
| vmin |  |  |  |
|  |  |  |  |
|  |  |  |  |
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|  |  |  |  |

# Results and Discussion

## Model Evaluation Metrics

We employed a binary classification strategy to identify classes that are likely to have defects. A binary classifier can make two types of errors: false positives (FP) and false negatives (FN). A correctly categorized defected class is also a true positive (TP), whereas a correctly classified non-defected class is a true negative (TN). We examined classification outcomes using the following metrics: Accuracy, Precision, Recall, and F-measure, described as follows:

* **Accuracy:** address the number or percentage of correctly classified instances to the total sum of instances. It can be calculated by Equation (1):

(1)

* **Precision:** Addresses the percentage of successfully classified defective occurrences among the total number of retrieved instances. The best precision value is 1. The higher the precision is, the fewer false positives. It can be calculated by Equation (2):

(2)

* **Recall:** Addresses The percentage of defective cases that were accurately classified. The best recall value is 1. The higher the recall is, the lower the number of false negatives. It can be calculated by Equation (3):

(3)

* **F-measure:** computes accuracy by taking Precision and Recall into account, which may be understood as a weighted average of Precision and Recall. The F-measure value varies between 0 and 1, with values closer to 1 indicating better classification results. It can be calculated by Equation (4):

(4)

* **G-mean:** A geometric mean of a true positive rate and a true negative rate, as in Equation (5):

(5)

## Analytical Description of the Relevant Features

|  |  |  |  |  |  |
| --- | --- | --- | --- | --- | --- |
| **Table 2:**  *Relevant features in software datasets.* | | | | | |
| **Project** | **All Features** | **Selected Features** | **FFR%** | **Relevant Features** |
| ant-1.7 | 21 | 1 |  |  |
| camel-1.6 | 21 | 1 |  |  |
| ivy-2.0 | 21 | 1 |  |  |
| jedit-4.3 | 21 | 1 |  |  |
| log4j-1.2 | 21 | 1 |  |  |
| lucene-2.4 | 21 | 1 |  |  |
| poi-3.0 | 21 | 1 |  |  |
| tomcat-6 | 21 | 1 |  |  |
| xalan-2.6 | 21 | 1 |  |  |
| xerces-1.4 | 21 | 1 |  |  |
| cm1 | 38 | 1 |  |  |
| jm1 | 22 | 1 |  |  |
| kc1 | 22 | 1 |  |  |
| kc3 | 40 | 1 |  |  |
| mc1 | 39 | 1 |  |  |
| mw1 | 38 | 1 |  |  |
| pc1 | 38 | 1 |  |  |
| pc2 | 37 | 1 |  |  |
| pc3 | 38 | 1 |  |  |
| pc4 | 38 | 1 |  |  |
| pc5 | 39 | 1 |  |  |

# Conclusions

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